Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	Applicant(s)/Pate Reexamination	
09/845,575	LAMBERT ET AL.	LAMBERT ET AI	
Examiner	Art Unit	Art Unit	
Quoc A. Tran	2176	2176	

SEARCHED			
Class	Subclass	Date	Examiner
709	219	8/30/2005	3
707	3	8/30/2005	(3)
709	217	12/22/2005	
Updated	Above	4/18/2006	33

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
715	513	1/12/2005	H
715	526	1/12/2005	20
715	501.1	1/12/2005	13

SEARCH NOT (INCLUDING SEARCH		)
	DATE	EXMR
USPAT, US-PGPUB (see search history printout)	8/30/2005	A
IEEE DataBase (see search history printout)	8/30/2005	À
Portal USPTO, ACM Dig Lib (see search history printout)	8/30/2005	8
USPAT, US-PGPUB (see search history printout)	12/22/05	0
EAST (USPAT, US-PGPUB, USOCR, EPO, JPO, DERWENT, IBM_TDB) (see search history printout)	4/18/2006	W.
Interference Search EAST (US- PGPUB) (see search history printout)	4/18/2006	3